

MOSFET - Power, Single, N-Channel, SO-8 FL 30 V, 69 A NTMFS4C906NB

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters

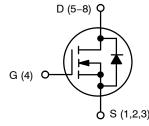
MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Symbol Value		
Drain-to-Source Voltage			V_{DSS}	30	V	
Gate-to-Source Voltage			V_{GS}	±20	V	
Continuous Drain Current R _{θJA} (Note 1)		$T_A = 25^{\circ}C$ $T_A = 80^{\circ}C$	I _D	20.0 14.9	Α	
Power Dissipation R ₀ JA (Note 1)		T _A = 25°C	P _D	2.55	W	
Continuous Drain Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		$T_A = 25^{\circ}C$ $T_A = 80^{\circ}C$	I _D	31.6 23.7	Α	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C P _D		6.4	W	
Continuous Drain Current R ₀ JA (Note 2)	State	$T_A = 25^{\circ}C$ $T_A = 80^{\circ}C$	I _D	11 8.2	Α	
Power Dissipation R _{0JA} (Note 2)		T _A = 25°C	P _D	0.77	W	
Continuous Drain Current R _{0JC} (Note 1)		$T_C = 25^{\circ}C$ $T_C = 80^{\circ}C$	Ι _D	69 52	Α	
Power Dissipation R _{0JC} (Note 1)		T _C = 25°C	P _D	30.5	W	
Pulsed Drain Current	T _A = 25°	C, t _p = 10 μs	I _{DM}	200	Α	
Current Limited by Page	ckage	T _A = 25°C	I _{Dmax}	80	Α	
Operating Junction and Storage Temperature Range		T _J , T _{STG}	-55 to +150	°C		
Source Current (Body Diode)		I _S	28	Α		
Drain to Source DV/DT		dV/d _t	7.0	V/ns		
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25 $^{\circ}$ C, V _{GS} = 10 V, I _L =37 A _{pk} , L = 0.1 mH, R _{GS} = 25 Ω) (Note 3)		E _{AS}	68	mJ		
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. Parts are 100% tested at $T_J = 25$ °C, $V_{GS} = 10$ V, $I_L = 27$ A_{pk} , EAS = 36 mJ.

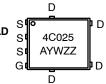
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
20.1/	3.41 mΩ @ 10 V	69 A
30 V	4.88 mΩ @ 4.5 V	US A



N-CHANNEL MOSFET

MARKING DIAGRAMS





A = Assembly Location

′ = Year

W = Work Week
ZZ = Lot Traceabililty

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4C906NBT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4C906NBT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	4.1	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	49	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	162.3	30/00
Junction-to-Ambient - (t ≤ 10 s) (Note 4)	$R_{\theta JA}$	19.5	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T.1 = 25°C unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS						1	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage (transient)	V _{(BR)DSSt}	V _{GS} = 0 V, I _{D(aval)} = 12.6 A, T _{case} = 25°C, t _{transient} = 100 ns		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				14.4		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C			1.0	μΑ
			T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.3		2.1	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				3.8		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		2.82	3.41	mΩ
		V _{GS} = 4.5 V	I _D = 25 A		4.01	4.88	
Forward Transconductance	9 _{FS}	V _{DS} = 1.5 V, I _D = 15 A			58		S
Gate Resistance	R_{G}	T _A = 25°C		0.3	1.0	2.0	Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			1683		pF
Output Capacitance	C _{OSS}				841		
Reverse Transfer Capacitance	C _{RSS}				40		
Capacitance Ratio	C _{RSS} /C _{ISS}	V _{GS} = 0 V, V _{DS} = 15 V, f = 1 MHz			0.023		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A			11.6		
Threshold Gate Charge	Q _{G(TH)}				2.6		nC
Gate-to-Source Charge	Q_{GS}				4.7		
Gate-to-Drain Charge	Q_{GD}				4.0		
Gate Plateau Voltage	V_{GP}				3.1		V
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V; I _D = 30 A			26		nC

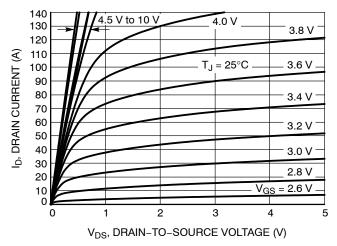
- 6. Pulse Test: pulse width \leq 300 $\mu s,$ duty cycle \leq 2%.
- 7. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified) (continued)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	lote 7)			•	•	•	
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			10		ns
Rise Time	t _r				32		
Turn-Off Delay Time	t _{d(OFF)}				18		
Fall Time	t _f				5.0		
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			8.0		ns
Rise Time	t _r				28		
Turn-Off Delay Time	t _{d(OFF)}				24		
Fall Time	t _f				3.0		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.8	1.1	
			T _J = 125°C		0.63		\ \
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/μs, I _S = 30 A			34		ns
Charge Time	t _a				17		
Discharge Time	t _b				17		
Reverse Recovery Charge	Qpp				22		nC

^{6.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
7. Switching characteristics are independent of operating junction temperatures.

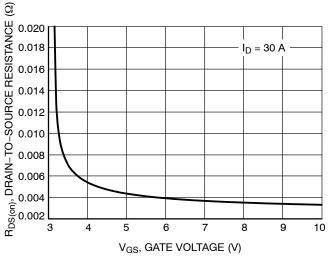
TYPICAL CHARACTERISTICS



80 70 $V_{DS} = 5 V$ ID, DRAIN CURRENT (A) 60 50 40 30 $T_J = 25^{\circ}C$ 20 $T_J = 125^{\circ}C$ 10 $T_J = -55^{\circ}C$ 0 0.5 1.0 1.5 2.5 3.0 3.5 2.0 V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



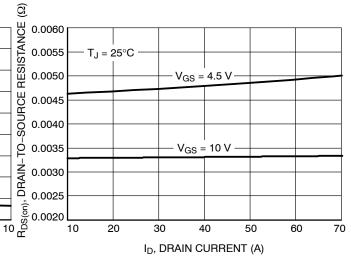
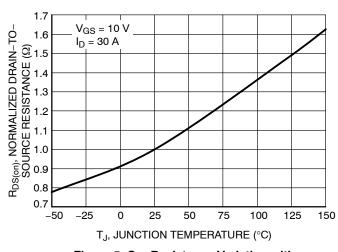


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



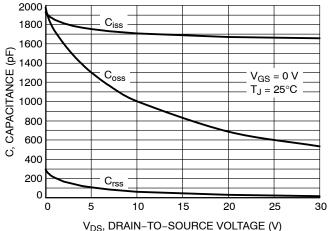


Figure 5. On-Resistance Variation with Temperature

Figure 6. Capacitance Variation

TYPICAL CHARACTERISTICS

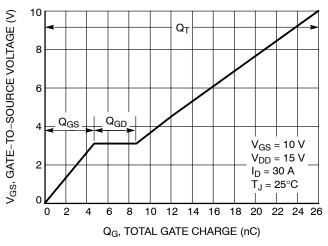


Figure 7. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

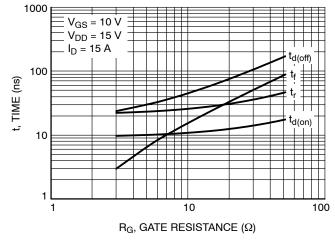


Figure 8. Resistive Switching Time Variation vs. Gate Resistance

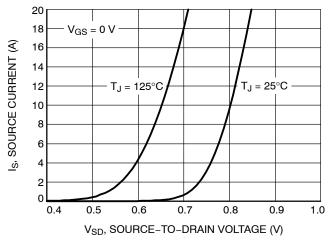


Figure 9. Diode Forward Voltage vs. Current

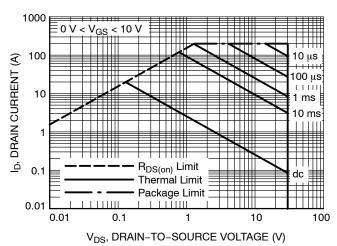


Figure 10. Maximum Rated Forward Biased Safe Operating Area

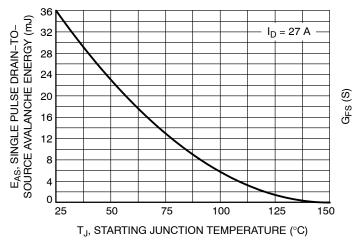


Figure 11. Maximum Avalanche Energy vs. Starting Junction Temperature

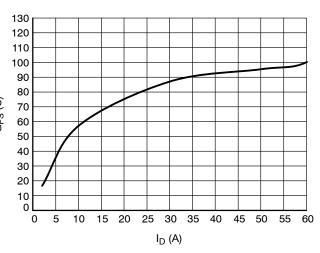


Figure 12. G_{FS} vs. I_D

TYPICAL CHARACTERISTICS

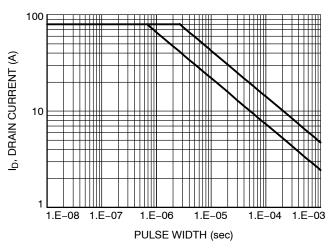


Figure 13. Avalanche Characteristics

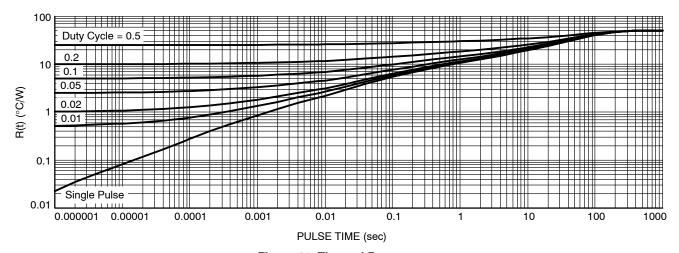
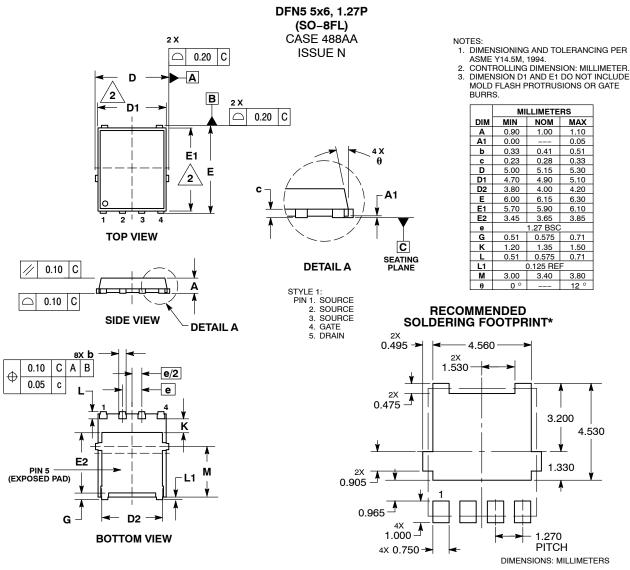


Figure 14. Thermal Response

PACKAGE DIMENSIONS



*For additional information on our Pb-Free strategy and soldering details, please download the **onsemi** Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

TECHNICAL SUPPORT

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative